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High-temperature thermal stability of Ti₂AlN and Ti₄AlN₃: A comparative diffraction study

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Abstract

The susceptibility of Ti₂AlN and Ti₄AlN₃ to high-temperature thermal dissociation in a dynamic environment of high-vacuum has been investigated using *in situ* neutron diffraction. Under high vacuum, these ternary nitrides decomposed above 1400 °C through the sublimation of Al, and possibly Ti, to form a surface coating of TiN_x ($0.5 \le x \le 0.75$). The kinetics of isothermal phase decomposition were modelled using the Avrami equation and the Avrami exponents (*n*) of isothermal decomposition of Ti₂AlN and Ti₄AlN₃ were determined to be 0.62 and 0.18, respectively. The characteristics of thermal stability and phase transitions in Ti₂AlN and Ti₄AlN₃ are compared in terms of the rate of decomposition, phase relations and microstructures.

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1. Introduction

MAX phases are nano-layered ceramics with the general formula $M_{n+1}AX_n$ (n = 1-3), where M is an early transition metal, A is a group A element, and X is either carbon and/or nitrogen. These materials exhibit a unique combination of characters of both ceramics and metals.^{1–5} Like ceramics, they have low density, low thermal expansion coefficient, high modulus and high strength, and good high-temperature oxidation resistance. Like metals, they are good electrical and thermal conductors, readily machinable, tolerant to damage, and resistant to thermal shock. The unique combination of these interesting properties enables these ceramics to be a promising candidate material for use in technologically important fields, especially in high temperature applications.

However, these MAX phases, and Ti_3SiC_2 in particular, are susceptible to thermal dissociation at ~ 1400 °C in inert

0955-2219/\$ - see front matter © 2010 Elsevier Ltd. All rights reserved. doi:10.1016/j.jeurceramsoc.2010.09.014 environments (e.g., vacuum or argon) to form a porous surface coating of TiC.^{6–11} Depth-profiling by X-ray diffraction of Ti₃SiC₂ annealed in vacuum at 1500 °C has revealed a graded phase composition with more than 90 wt% TiC on the surface and decreasing rapidly with an increase in depth.^{6,7} A similar phenomenon has also been observed for Ti₃AlC₂ whereby it decomposed in vacuum to form TiC and Ti₂AlC.¹⁰ It follows that this process of thermal dissociation to form protective coatings of binary *MX* can be expected to occur in ternary nitrides Ti₂AlN, Ti₄AlN₃ and Nb₄AlN₃.

The fundamental knowledge about the thermal stability of technologically important MAX phases is still very limited and the actual process of phase dissociation is poorly understood. This limited understanding has generated much controversy concerning the high-temperature thermochemical stability of MAX phases.^{12–21} For instance, Zhang et al.¹⁸ reported Ti₃SiC₂ to be thermally stable up to 1300 °C in nitrogen, but above this temperature drastic degradation and damage occurred due to surface decomposition. Feng et al.¹⁹ only observed TiC on the surface of Ti₃SiC₂ annealed at 1600–2000 °C in vacuum. According to Gao et al.²⁰ the propensity of decomposition of Ti₃SiC₂ to TiC

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was related to the vapour pressure of Si at temperatures above 1400 °C. This process of surface-initiated phase dissociation was even observed to commence as low as 1000–1200 °C in Ti₃SiC₂ thin films during vacuum annealing.¹⁷ The large difference in observed dissociation temperatures between bulk and thin-film Ti₃SiC₂ has been attributed to the difference in diffusion length scales involved and measurement sensitivity employed in the respective studies.

In contrast, Barsoum and El-Raghy¹⁵ observed that decomposition of Ti₃SiC₂ at 1600 °C commenced after annealing for 24 h in vacuum, but after only 4 h in an argon atmosphere. They further argued that the reduced temperature at which Ti₃SiC₂ decomposed as observed by others was due to the presence of impurity phases (e.g. Fe or V) in the starting powders which interfered with the reaction synthesis of Ti₃SiC₂, and thus destabilised it following prolonged annealing in an inert environment.²¹ However, mixed results have been reported by Radakrishnan et al.¹⁶ where Ti₃SiC₂ was shown to be stable in a tungsten-heated furnace for 10 h at 1600 °C and 1800 °C in an argon atmosphere, but dissociated to TiC_x under the same conditions when using a graphite heater. These conflicting results suggest that the thermochemical stability of MAX phases is still poorly understood although its susceptibility to thermal dissociation is strongly influenced by factors such as the purity of powders and sintered materials, temperature, sintering pressure, atmosphere, and the type of heating elements used.

Although a few studies have been conducted on the thermal stability of *312* (M₃AX₂) phases, virtually no work has been reported for the *211* (M₂AX) or *413* (M₄AX₃) phases such as Ti₂AlC, Ti₂AlN, Ta₄AlC₃ and Ti₄AlN₃. We have recently investigated the thermal stability of Ti₃SiC₂, Cr₂AlC, Ti₂AlC and Ti₃AlC₂ in vacuum at up to 1550 °C and the results indicated 211 phases to be more resistant to phase dissociation than 312 phases.^{8–10} For instance, both Ti₃SiC₂ and Ti₃AlC₂ decomposed readily to TiC forming intermediate phases of Ti₅Si₃C and Ti₂AlC respectively. The apparent activation energies for the decomposition of sintered Ti₃SiC₂, Ti₃AlC₂ and Ti₂AlC were determined to be 179.3, -71.9 and 85.7 kJ mol⁻¹, respectively.^{9,10}

Hitherto, virtually no work has been reported for ternary nitrides such as Ti_2AIN and Ti_4AIN_3 . It also remains unknown whether these MAX phases will decompose in a similar manner to 211 and 312 ternary carbides via the sublimation of group *M* element and the de-intercalation of group *A* element as follows:

$$M_{n+1}AX_n \to (n+1)MX_{\left(\frac{n}{n+1}\right)} + A \tag{1}$$

In this paper, we describe the use of high-temperature neutron diffraction to study *in situ* the dynamic processes of phase decomposition and transitions of Ti_2AIN and Ti_4AIN_3 under high-vacuum. The kinetics of isothermal phase decomposition were modelled using the Avrami equation and the Avrami constants were evaluated. The characteristics of thermal stability and phase transitions in Ti_2AIN and Ti_4AIN_3 are compared and discussed.

2. Experimental procedure

2.1. Material synthesis

Dense hot-pressed cylindrical bar samples of Ti₂AlN and Ti₄AlN₃ with dimensions of 10 mm diameter and 20 mm height were used in this study. These samples were prepared according to the procedures previously reported by Zhou and co-workers²² and Barsoum and co-workers,²³ respectively. The resultant samples contained ~6.9 and ~0.8 wt% TiN, respectively, and had \leq 0.5% porosity.

2.2. In situ neutron diffraction

In situ time of flight (TOF) powder neutron diffraction was used to monitor the structural evolution of phase decomposition in Ti₂AlN at high temperature in real time. Diffraction patterns were collected using the Polaris medium resolution, high intensity powder diffractometer at the UK pulsed spallation neutron source ISIS, Rutherford Appleton Laboratory.²⁴ Samples were held in a basket made from thin tantalum wire and mounted in a Risø-design high temperature furnace (Risø National Laboratory, Roskilde). Fitted with a thin tantalum foil element and tantalum and vanadium heat shields, this furnace is capable of reaching 2000 °C and operates under a high dynamic (i.e., continuously pumped) vacuum ($<7.5 \times 10^{-6}$ Torr). Temperature monitoring and control was achieved using type W5 thermocouples, positioned $\sim 10 \,\mathrm{mm}$ above the samples (so as not to be in the incident neutron beam). Collimating slits (manufactured from neutron-absorbing boron nitride) mounted on the furnace in the scattered beam direction enable diffraction patterns free from Bragg reflections off the tantalum element and heat shields to be collected in the Polaris $2\theta = 90^{\circ}$ detectors. A precision electronic scale (reading to five decimal places) was used to weigh the sample before it was loaded into the furnace.

For each sample, a reference diffraction pattern was collected at room temperature while the furnace was initially evacuated, then the sample was heated rapidly up to a selected temperature (e.g. 1500, 1550, 1600, 1700, and 1800 °C) where it was held constant for an extended period during which a series of diffraction patterns, each of 15 min duration, were collected. The total time spent at each elevated temperature was manually controlled, based on the level of decomposition observed in the diffraction patterns as they were collected. At the end of each high temperature measurement the furnace was cooled to room temperature, and the sample carefully removed from the furnace and weighed again in order to determine the mass of titanium and aluminium lost through evaporation.

Normalised data collected in the $2\theta \sim 90^{\circ}$ detector bank over the time-of flight range (1500–19200 µs (corresponding to a *d*-spacing range of ~0.4–4.2 Å)) were analysed using (a) the LAMP software and (b) the Fullprof software to compute the changes in the phase content of MAX phases and TiN formed during vacuum-annealing at elevated temperatures. In the former, the integrated peak intensities of lines (013) and (111) were used for calculating the relative phase content of Ti₄AlN₃ and TiN respectively. In the latter, the Rietveld method was used to compute the phase content of Ti₂AlN and TiN during vacuum-annealing. The Rietveld method is a least-square-based refinement method which is used to obtain the best fit between the calculated and the observed diffraction patterns.²⁵ This method is widely used for refining crystal structural data using powder diffraction data to extract phase-specific information from materials. In the least-square procedure, a best-fitted model is obtained when the residuals (R_{wp} , R_{exp} , GOF) are minimised whereby,

$$R_{\rm wp} = \left\{ \frac{\sum w_i [Y_i(obs) - Y_i(calc)]^2}{\sum w_i [Y_i(obs)]^2} \right\}^{1/2}$$
$$R_{\rm exp} = \left[\frac{N - P}{\sum w_i Y_i^2(obs)} \right]^{1/2}$$
$$GOF = \left[\frac{R_{\rm wp}}{R_{\rm exp}} \right]^2 = \frac{\sum w_i [Y_i(obs) - Y_i(calc)]^2}{N - P}$$

Here, I(obs) is the "observed" integrated intensity of Bragg reflection at the end of the refinement after distributing the contributing peaks and background to the calculated integrated intensity I(calc); N is the number of observations; P is the number of adjusted parameters; N - P is the number of degrees of freedom in the least squares system; GOF denotes the goodnessof-fit of the calculated pattern to the experimental.

The variation of unit cell volume as a function of temperature was determined and the coefficient of linear thermal expansion (CTE) was evaluated using the equation:

$$CTE = \frac{\Delta V}{V \Delta T}$$
(2)

The kinetic behaviour of the isothermal decomposition of Ti_4AlN_3 and Ti_2AlN at 1500 and 1550 °C, respectively, was modelled using the Avrami equation to describe the fraction of decomposed MAX phase (*y*) as a function of time (*t*):²⁶

$$y = \exp(-kt^n) \tag{3}$$

where k and n are time-independent constants for the particular reaction.

2.3. Synchrotron radiation diffraction

Thin flat-plates of Ti₄AlN₃ and Ti₂AlN, which had been vacuum-decomposed at various temperatures were analysed on beamline 20B of the Photon Factory using the BIGDIFF diffractometer.²⁷ Imaging plates were used to record the patterns over the 2θ range of 2–90°. The diffractometer was operated in Debye–Scherrer mode under vacuum with wavelength of 0.7 Å and at an incident angle of 3°.

2.4. Scanning electron microscopy

The surface microstructures of the decomposed samples were examined using scanning electron microscopy. The images were acquired using SEM (Manufacturer: Zeiss, Germany; Model:



Fig. 1. Phase evolution during the vacuum decomposition of Ti_4AlN_3 at up to 1600 $^\circ\text{C}.$



Fig. 2. Phase evolution during the vacuum decomposition of Ti_2AlN at up to 1800 $^\circ\text{C}.$

EVO 40XVP) with an accelerating voltage of 15 keV. The samples were not gold or carbon-coated prior to the microstructure examination.

3. Results and discussion

3.1. Thermal decomposition and phase transitions

The phase decompositions of Ti₂AlN and Ti₄AlN₃ at various temperatures as revealed by *in situ* neutron diffraction are shown in Figs. 1–3 and these are verified by the plots of synchrotron radiation diffraction patterns shown in Fig. 4. For Ti₄AlN₃, it began to decompose to TiN_x quite slowly at 1450 °C but became more rapid above 1500 °C (Fig. 1) and was almost completely decomposed after annealing at 1600 °C for less than 30 min. A total weight loss of ~11.6% and 5.9% was observed for ~2h decomposition at 1600 and 1500 °C, respectively, which may



Fig. 3. Diffraction patterns of Ti₂AlN vacuum annealed at: (a) $20 \,^{\circ}$ C; (b) $1400 \,^{\circ}$ C; (c) $1600 \,^{\circ}$ C/10 min; (d) $1600 \,^{\circ}$ C/40 min; (e) $1600 \,^{\circ}$ C/80 min; (f) $1600 \,^{\circ}$ C/130 min; and (g): cooled to $20 \,^{\circ}$ C. Note the formation of Ti₄AlN₃ at $1600 \,^{\circ}$ C [legend: * = Ti₄AlN₃; ** = TiN].



Fig. 4. Synchrotron radiation diffraction plots showing the diffraction patterns of (a) TiN, (b) Ti₄AlN₃, (c) Ti₂AlN, (d) Ti₂AlN vacuum-annealed at 1550 °C, (e) Ti₄AlN₃ vacuum-annealed at 1600 °C, and (f) Ti₂AlN vacuum-annealed at 1800 °C. Note that the plots for (a)–(c) are based on theoretical calculations.

be attributed mainly to the release of gaseous Al by sublimation during the decomposition process. This amount of weight loss is consistent with the fact that there is about 10.4 wt% of Al in Ti₄AlN₃ and these results concur with our previous work on ternary carbides.^{9–12} It is worth mentioning that a lower order Ti₂AlN was not observed during the decomposition of Ti₄AlN₃ which suggests that a decomposition process via an intermediate 211 phase is thermodynamically impossible, i.e.,

$$Ti_4AIN_3 \neq Ti_2AIN + 2TiN \tag{4}$$

Instead, Ti_4AlN_3 decomposes directly to form $TiN_{0.75}$ via sublimation or de-intercalation of Al from its crystal layer structure, i.e.,

$$Ti_4AlN_3 \rightarrow 4TiN_{0.75} + Al_{(g)} \tag{5}$$

The Rietveld software Fullprof was used to analyse the neutron diffraction patterns for Ti₂AlN. The goodness-of-fit (GOF) ranged from 1.2 to 1.3 and satisfactory residual values of refinements were obtained for R_{wp} and R_B . Typical plots of Rietveld profile fit are shown in Fig. 5 for Ti₂AlN before and after vacuum decomposition. The distinct sample decomposition as a result of vacuum annealing at elevated temperature is evident.

The in situ decomposition of Ti2AlN was observed to behave quite differently from that of Ti₄AlN₃. In spite of having a higher content of TiN as impurity, Ti2AlN appeared to be much more stable against decomposition than Ti₄AlN₃. It began to decompose to TiN slowly after 1550 °C but became quite rapid at 1600 °C (Fig. 2). It was almost completely decomposed after annealing at 1700 °C for just over 2 h and at 1800 °C for about 20 min. A total weight loss of more than 20.0% was observed for decomposition at 1600 °C and above. Below 1600 °C, the weight loss was 5.0% and 0.95% at 1550 °C and 1500 °C, respectively. Noting that there is about 19.7 wt% of Al in Ti₂AlN, we deduce that the weight loss in decomposed Ti₂AlN is entirely due to sublimation of aluminium when its vapour pressure rises above the ambient pressure of the furnace. This is not surprising when we consider that the vapour pressure of aluminium metal rises rapidly from $\sim 7 \times 10^{-3}$ Torr at 1200 °C to ~ 0.5 Torr at 1500 °C. By contrast the vapour pressure for titanium metal is more than three orders of magnitude lower in this temperature range.²⁸ Thus, at temperatures higher than 1500 °C, we might expect Al to become quite volatile and sublime continuously in a dynamic environment of high vacuum, leading to severe decomposition of Ti2AIN with the concomitant formation of non-stoichiometric TiN_x, i.e.,

$$\operatorname{Ti}_{2}\operatorname{AlN}_{(s)} \xrightarrow{T \ge 1500^{\circ}\mathrm{C}} 2\operatorname{TiN}_{0.5} + \operatorname{Al}_{(g)}$$

$$\tag{6}$$

However, the possibility of an additional but very small amount of Ti metal sublimation from the weak metallic Ti–C bonds cannot be ruled out because the vapour pressure of Ti is almost 10^{-2} Torr at 1700 °C. This conclusion was strongly supported by visual inspection of samples and furnace inserts after decomposition, where aluminium and possibly titanium coatings covered most surfaces.

A closer look at Fig. 2 shows that a new phase Ti₄AlN₃ formed when Ti₂AlN was vacuum-annealed at 1600 °C and its abundance increased with time and persisted when cooled down to room temperature (Fig. 3). This process of $211 \rightarrow 413$ transformation has also been reported by Hu et al.^{29,30} for the decomposition of Ta₂AlC into Ta₄AlC₃ and Nb₂AlC to Nb₄AlC₃ in argon at high temperature, probably *via* the intercalation of the formed binary carbide into the 211 structure. However, it disappeared when the temperature was increased to 1700 °C and above.

We propose that the formation of Ti_4AlN_3 during vacuum annealing of Ti_2AlN at 1600 °C occurs *via* the intercalation of TiN in Ti_2AlN as follows:

$$Ti_2AIN_{(s)} + 2TiN_{(s)} \xrightarrow{1600^{\circ}C} Ti_4AIN_3$$
(7)

At temperatures above $1600 \,^{\circ}$ C, Ti₄AlN₃ becomes unstable and decomposes into TiN_{0.75} *via* the sublimation of highly volatile Al (see Eq. (5)).

As previously mentioned, the weight losses of up to 11.6%and over 20% in decomposed Ti₄AlN₃ and Ti₂AlN, respectively, can be attributed to the release of gaseous Al (and possibly Ti) by sublimation during the decomposition process because the



Fig. 5. The Rietveld profile fit of diffraction data of Ti₂AlN collected (a) before decomposition at 20 °C {GOF = 1.2; $R_{wp} = 34.8$; $R_{exp} = 31.4$ } and (b) after vacuum annealing at 1550 °C {GOF = 1.2; $R_{wp} = 47.9$; $R_{exp} = 43.7$ }. Measured patterns indicated by crosses, calculated pattern indicated by solid line. Intensity differences between the two patterns are shown along the bottom of the plot. Vertical bars represent the allowable peak positions for the phases. (Top: Ti₂AlN ICSD #52641; bottom: TiN_x ICSD #658338).

vapour pressures of both Al and Ti exceed the ambient pressure of the furnace (i.e., $\leq 5 \times 10^{-5}$ Torr) at $\geq 1500 \,^{\circ}\text{C}^{.28}$ Since the vapour pressure of a substance increases non-linearly with temperature according to the Clausius–Clapeyron relation,³¹ the volatility of Al and Ti will increase with any incremental increase in temperature. Fig. 6 shows the vapour pressures of various elements at elevated temperature, and at a vapour pressure of 5×10^{-2} Torr in the vacuum furnace, both Al and Ti become volatile as the temperature approaches 1200° and 1700 °C, respectively. Thus, at the temperature of well over 1500 °C used in this study, both Al and a small amount of Ti should become volatile and sublime readily and continuously in a dynamic environment of high vacuum. When the vapour pressure becomes sufficient to overcome ambient pressure in the vacuum furnace, bubbles will form inside the bulk of the substance which eventually appear as voids on the surface of decomposed MAX phase. $^{9-12}$ The evidence of voids formation can be clearly discerned from the porous or "crater-like" surface damage of decomposed Ti₂AlN and Ti₄AlN₃ as shown in the optical photos of Fig. 7 and verified by the scanning electron micrographs in Fig. 8. A closer look of Fig. 6 may further explain why Ti₃SiC₂ is more resistant to decomposition than Ti₃AlC₂ or Ti₄AlN₃ because Si has a lower vapour pressure than Al. Thus, the use of vapour pressure of elements shown in Fig. 6 can be used to predict the susceptibility of MAX phases to thermal decomposition.

The variations of unit cell edges with temperature of all the phases and the corresponding coefficients of thermal expansion coefficient (CTE) are shown in Table 1. As would be expected, all the lattice parameters increased with increasing temperature by virtue of thermal expansion. However, the unit cell edges remained fairly constant with time up to 440 min at a particular isothermal annealing temperature. In addition, the calculated values of linear thermal expansion coefficient for Ti_4AIN_3 and Ti_2AIN shown in Table 1 are comparable with literature results.¹ However, it should be noted that the CTE of TiN_x reported here



Fig. 6. Vapour pressure of selected elements at various temperatures.²⁸



[(a) Before decomposition; (b) after decomposition at 1600°C for 440 min.]



[(a) Before decomposition; (b-d) after decomposition at 1500°C/120 min, 1700°C/40 min & 1800°C/20 min]

Fig. 7. Surface conditions of (i) Ti_4AlN_3 and (ii) Ti_2AlN before and after thermal decomposition during vacuum-annealing.

(i.e. $8.15 \times 10^{-6} \,\text{K}^{-1}$) is much lower than that of stoichiometric TiN which is about $9.35 \times 10^{-6} \,\text{K}^{-1}$).¹ This verifies the formation of non-stoichiometric TiN_x during vacuum-annealing of ternary nitrides at elevated temperature.

3.2. Isothermal phase decomposition and Avrami kinetics

Fig. 9 shows the phase composition, determined by measuring the area under the indicated Bragg reflections, during the isothermal decomposition of Ti_4AlN_3 at 1500 °C which was quite rapid initially but slowed down significantly after 30 min. More than 60% of Ti_4AlN_3 decomposed after vacuum annealing at 1500 °C for 400 min. In contrast, the decomposition for Ti_2AlN was much slower with only 20% decomposed after 300 min at 1550 °C (Fig. 10). This implies that Ti_2AlN has a significantly higher resistance to thermal decomposition

Table 1

Variations of unit cell edges as a function of temperature and the coefficient of linear thermal expansion (CTE) for Ti_2AIN , $Ti_4AIN_{2.9}$ and TiN_x .

Temperature (°C)	Ti ₂ AlN		Ti ₄ AlN _{2.9}		TiN _x	
	a	с	a	С	а	
25	2.984	13.579	2.994	23.402	4.244	
1100	3.025	13.747	3.014	23.535	4.281	
1400	3.036	13.794	3.020	23.573	4.292	
1500	3.040	13.809	3.022	23.585	4.295	
1550	3.042	13.817	3.023	23.591	4.297	
1600	3.044	13.825	3.024	23.597	4.298	
1700	_	_	_	_	4.302	
1800	_	_	_	_	4.311	
CTE (10 ⁻⁶ /°C)	12.746	11.493	6.340	5.302	8.153	



(a) Ti₄AlN₃



(b) Ti₂AlN

Fig. 8. Scanning electron micrographs showing the porous or "crater-like" surface microstructure of (a) Ti_4AlN_3 and (b) Ti_2AlN after thermal decomposition in vacuum at elevated temperature.

than Ti₄AlN₃. A possible reason for the high susceptibility of Ti₄AlN₃ to decomposition is either the existence of a lower order 211 phase or the much weaker Al-Ti bonding in this more complex layered compound where Al lies in every fifth layer.^{1,3} In contrast, in the 211 compound the Al atoms are located in every third layer, resulting in shorter but stronger Al–Ti bonds which



Fig. 9. Time-dependent phase abundance and Avrami fit of isothermal decomposition of Ti_4AlN_3 at 1500 $^\circ\text{C}.$



Fig. 10. Time-dependent phase abundance and Avrami fit of isothermal decomposition of Ti₂AlN at 1550 $^{\circ}$ C.

Table 2	
Comparison of the Avrami decomposition kinetics in MAX 211 and 41	3 phases.

MAX phase	Avrami exponent (n)	Avrami constant (k) mol% (min) ^{$-n$}
Ti ₄ AlN ₃	0.18	0.37
Ti ₂ AlN	0.62	0.004

provides more resistance to decomposition via out-diffusion of Al from the bulk to the surface.

During the isothermal decomposition of 211 and 413 phases at 1550 and 1500 °C, the Avrami kinetics of decomposition was modelled using Eq. (3) and the Avrami constants were evaluated. The Avrami fit of the isothermal decomposition of Ti₄AlN₃ and Ti₂AlN is shown in Figs. 9 and 10, respectively. The calculated Avrami exponent (n) and Avrami constant (k) for the two MAX phases are summarised in Table 2. In general, when the value of *n* is large (e.g., 3 or 4), a 3-dimensional nucleation and growth process is involved.³² High values of n can also occur when nucleation occurs on specific sites such as grain boundaries or impurities which rapidly saturate soon after the transformation begins. Initially, nucleation may be random and growth unhindered leading to high values for n. Once the nucleation sites are consumed the transformation will slow down or cease. Furthermore, if the distribution of nucleation sites is non-random then the growth may be restricted to 1 or 2-dimensions. Site saturation may lead to n values of 1, 2 or 3 for surface, edge and point sites, respectively.²¹ Since the values of n obtained in this study for both 211 and 413 phases are less than 1.0, this implies that the decomposition process is driven by highly restricted out-diffusion of aluminium from the bulk to the surface of the sample and into the vacuum.

4. Conclusions

The high-temperature thermal stability of Ti_2AIN and Ti_4AIN_3 in a dynamic environment of high-vacuum has been studied using *in situ* neutron diffraction. Both 211 and 413 phases were susceptible to decomposition above 1400 °C

through sublimation of Al and possibly a small amount of Ti, resulting in a layer of TiN_x ($0.5 \le x \le 0.75$) being formed on the surface of the sample. The kinetics of isothermal phase decomposition was modelled using the Avrami equation and the Avrami constants *n* for the isothermal decompositions of Ti₂AlN and Ti₄AlN₃ indicate that in both cases the decomposition is a highly restricted diffusion process, presumably of aluminium from the bulk of the sample to its surface (from where it enters the vacuum of the furnace).

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